



SSCG40R120GT2

Trench FSII Fast IGBT

➤ Features

V_{CES}	V_{GES}	I_c
1200V	$\pm 20V$	80A@25°C
		40A@100°C

➤ Description

- Trench and field-stop technology
- High speed switching
- Low collector to emitter saturation voltage
- Easy parallel switching capability
- Short circuit withstands time 10 μ s
- High ruggedness performance

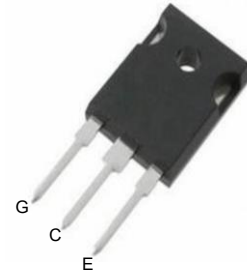
➤ Applications

- General inverter
- Motor drives

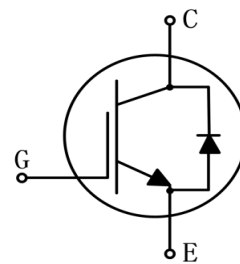
➤ Ordering Information

Device	Package	Shipping
SSCG40R120GT2	TO-247-3L	30/Tube

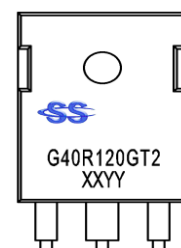
➤ Pin Configuration



TO-247-3L (Top View)



Pin Configuration



Marking

(XYYY: Internal Traceability Code)



➤ **Absolute Maximum Ratings ($T_{vj}=25^{\circ}\text{C}$ unless otherwise noted)**

Symbol	Parameter		Ratings	Unit
V_{CES}	Collector-Emitter Voltage		1200	V
V_{GES}	Gate-Emitter Voltage		± 20	V
I_C	Collector Current	$T_C=25^{\circ}\text{C}$	80	A
		$T_C=100^{\circ}\text{C}$	40	
I_{Cpuls}	Pulsed Collector Current, t_p limited by T_{vjmax}		160	A
P_D	Power Dissipation ^a	$T_C=25^{\circ}\text{C}$	625	W
		$T_C=100^{\circ}\text{C}$	312	
T_J	Operating Junction and Storage Temperature Range		-40~175	$^{\circ}\text{C}$
T_{STG}	Operating Junction and Storage Temperature Range		-55~150	$^{\circ}\text{C}$
t_{sc}	Short circuit withstand time		10	us

➤ **Thermal Resistance Ratings**

Symbol	Parameter	Typ	Max	Unit
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance		40	$^{\circ}\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance, Junction to Case for IGBT		0.24	
$R_{\theta JC}$	Thermal Resistance, Junction to Case for Diode		0.49	



➤ **Electrical Characteristics of IGBT ($T_{vj}=25^{\circ}\text{C}$ unless otherwise noted)**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CES}$	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_C = 0.25mA$	1200			V
I_{CES}	Collector-Emitter Leakage Current	$V_{GE}=0V, V_{CE}=1200V, T_{vj}=25^{\circ}\text{C}$			250	μA
$I_{GES(F)}$	Gate to Emitter Forward Leakage	$V_{GE} = +20V, V_{CE} = 0V$			100	nA
$I_{GES(R)}$	Gate to Emitter Reverse Leakage	$V_{GE} = -20V, V_{CE} = 0V$			-100	nA
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C=40A, V_{GE}=15V, T_{vj}=25^{\circ}\text{C}$		1.7		V
		$I_C=40A, V_{GE}=15V, T_{vj}=175^{\circ}\text{C}$		2.3		V
$V_{GE(th)}$	Gate Threshold Voltage	$I_C = 1mA, V_{CE} = V_{GE}$	5.0	6.0	7.0	V
C_{ies}	Input Capacitance	$V_{CE} = 30V, V_{GE} = 0V, f = 1MHz$		3210		pF
C_{oes}	Output Capacitance			198		
C_{res}	Reverse Transfer Capacitance			29		
$T_{D(ON)}$	Turn-on delay time	$T_{vj}=25^{\circ}\text{C}, V_{CC}=600V, I_C=40A, V_{GE}=0/15V, R_g=10\Omega, \text{ Inductive Load}$		42		ns
T_r	Rise time			101		
$T_{D(OFF)}$	Turn-off delay time			266		
T_f	Fall time			70		
E_{on}	Turn-On Switching Loss			4.0		mJ
E_{off}	Turn-Off Switching Loss			1.8		
E_{ts}	Total Switching Loss			5.8		
$T_{D(ON)}$	Turn-on delay time	$T_{vj}=175^{\circ}\text{C}, V_{CC}=600V, I_C=40A, V_{GE}=0/15V, R_g=10\Omega, \text{ Inductive Load}$		42		ns
T_r	Rise time			108		
$T_{D(OFF)}$	Turn-off delay time			290		
T_f	Fall time			127		
E_{on}	Turn-On Switching Loss			6.0		mJ
E_{off}	Turn-Off Switching Loss			2.7		
E_{ts}	Total Switching Loss			8.7		
Q_G	Total Gate Charge	$V_{CC} = 960V, I_C = 40A, V_{GE} = 0/15V$		191		nC



➤ **Electrical Characteristics of Diode ($T_{vj}=25^{\circ}\text{C}$ unless otherwise noted)**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
VF	Diode forward voltage	IF=40A, $T_{vj}=25^{\circ}\text{C}$		2.0		V
		IF=40A, $T_{vj}=175^{\circ}\text{C}$		1.6		V
Trr	Diode reverse recovery time	VR=600V IF=40A diF/dt=750A/ μs $T_{vj}=25^{\circ}\text{C}$		175		ns
Irrm	Diode peak reverse recovery current			24		A
Qrr	Diode reverse recovery charge			2000		nC
Trr	Diode reverse recovery time	VR=600V IF=40A diF/dt=750A/ μs $T_{vj}=175^{\circ}\text{C}$		285		ns
Irrm	Diode peak reverse recovery current			37		A
Qrr	Diode reverse recovery charge			5500		nC

➤ **Typical Performance Characteristics ($T_{vj}=25^{\circ}\text{C}$ unless otherwise noted)**

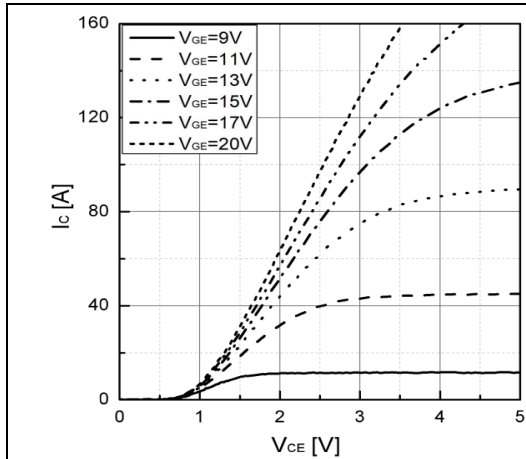


Fig 1. Typical output characteristic ($T_{vj}=25^{\circ}\text{C}$)

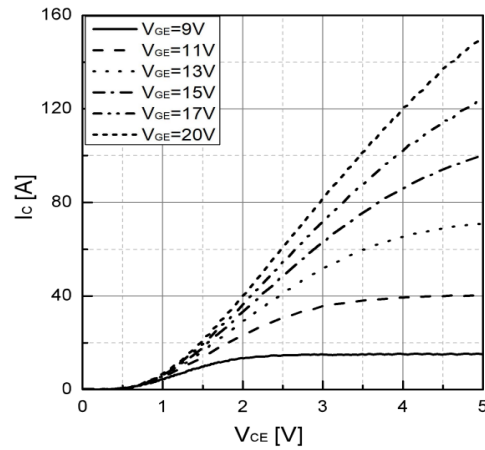


Fig 2. Typical output characteristic ($T_{vj}=175^{\circ}\text{C}$)

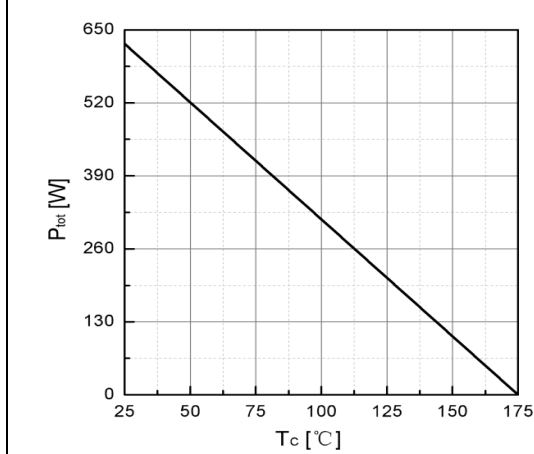


Fig 3. Power dissipation as a function of TC

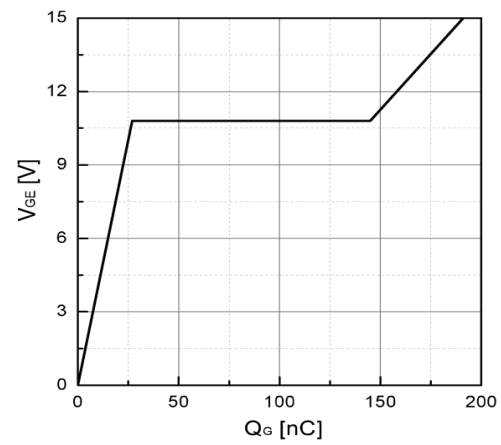
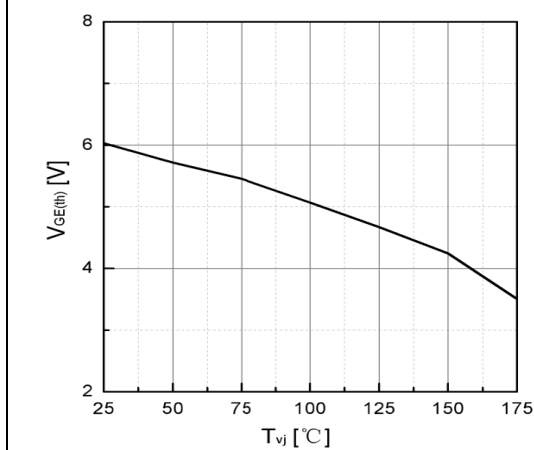


Fig 4. Typical Gate charge



**Fig 5. Typical $V_{GE(th)}$ as a function of T_{vj}
($I_C=1\text{mA}$)**

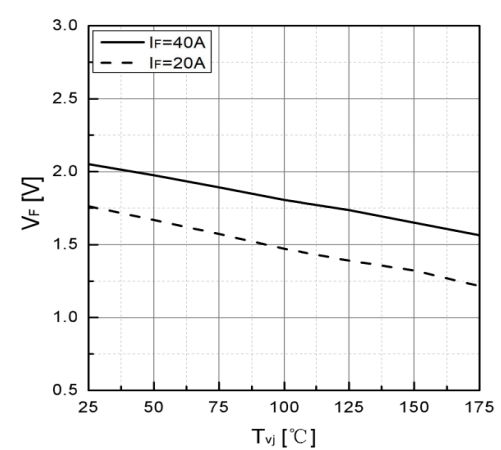


Fig 6. Typical V_F as a function of T_{vj}

➤ **Typical Performance Characteristics ($T_{vj}=25^{\circ}\text{C}$ unless otherwise noted)**

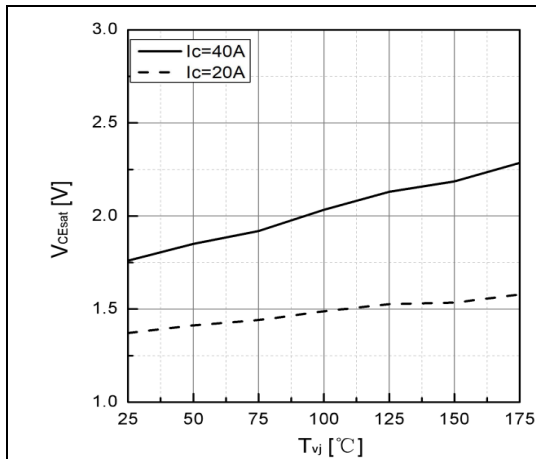


Fig 7. Typical VCEsat as a function of T_{vj}

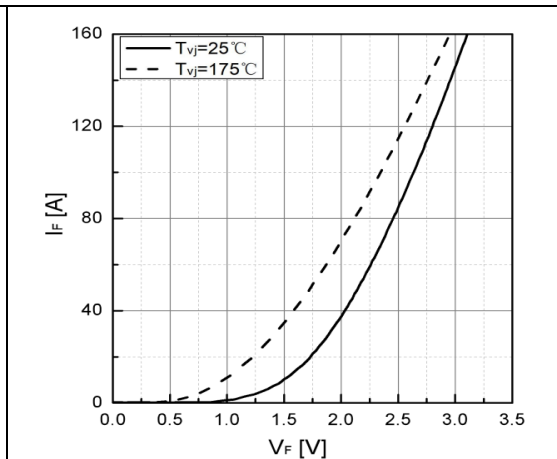


Fig 8. Typical IF as a function of V_F

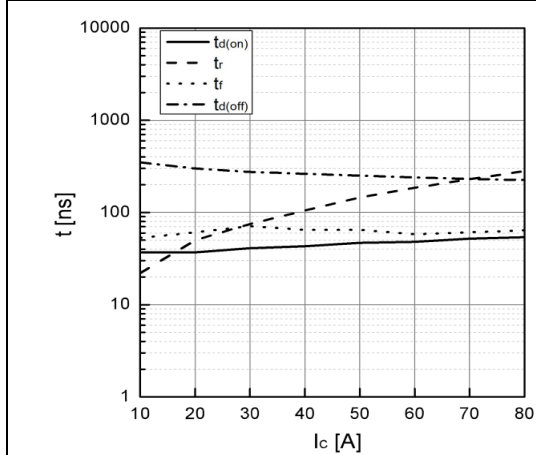


Fig 9. Typical switching time as a function of I_C

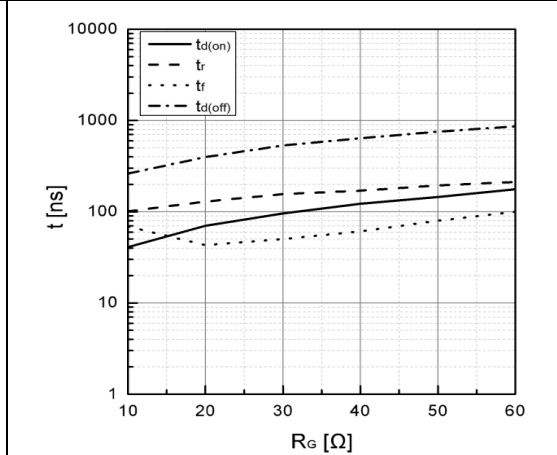


Fig 10. Typical switching times as a function of R_G

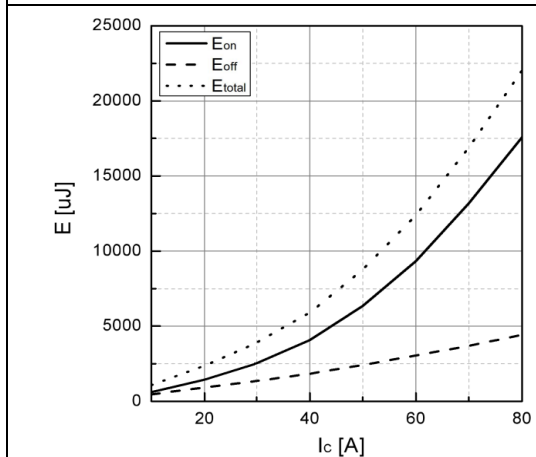


Fig 11. Typical switching energy losses as a function of I_C

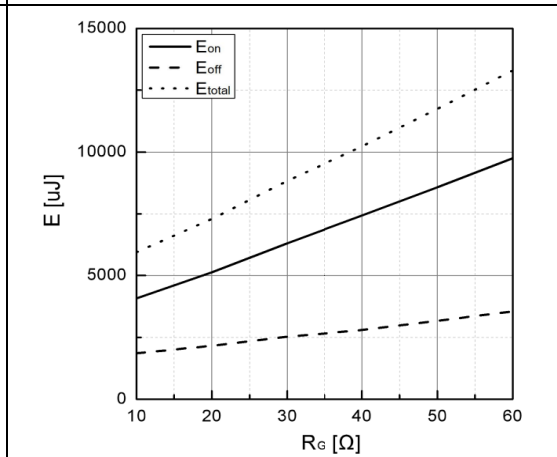


Fig 12. Typical switching energy losses as a function of R_G

➤ **Typical Performance Characteristics ($T_{vj}=25^{\circ}\text{C}$ unless otherwise noted)**

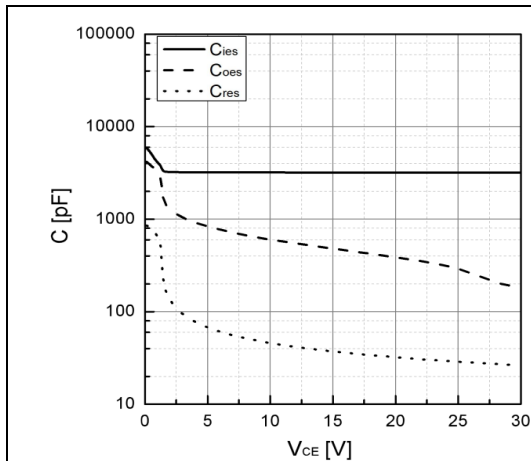


Fig 13. Typical capacitance as a function of $V_{CE}(f=1\text{MHz}, V_{GE}=0\text{V})$

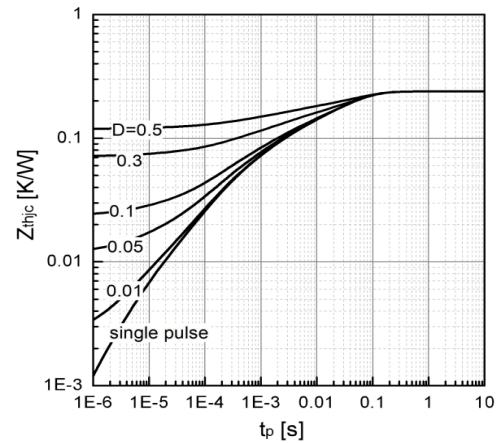


Fig 14. Transient thermal impedance, IGBT

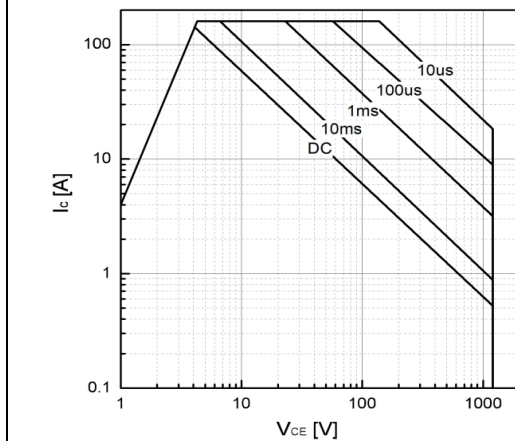
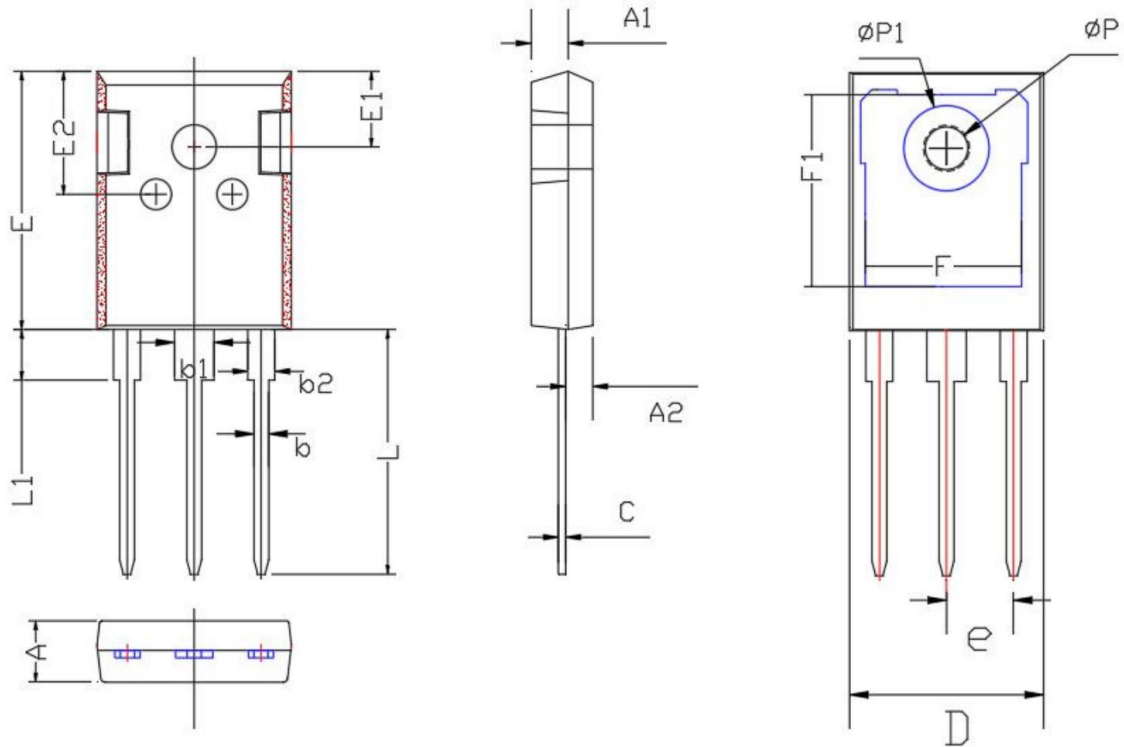


Fig 15. Safe operating area

➤ Package Information

TO247



Symbol	MILL IMETER			Symbol	MILL IMETER		
	Min	Nom	Max		Min	Nom	Max
A	4.80	5.00	5.20	E1	5.60	5.80	6.20
A1	3.30	3.50	3.70	E2	9.8	10.0	10.2
A2	2.20	2.40	2.60	e	5.25	5.45	5.65
b	1.00	1.20	1.40	F	13.1	13.4	13.7
b1	2.90	3.10	3.30	F1	16.25	16.55	16.85
b2	1.90	2.10	2.30	L	19.5	20.0	20.5
c	0.50	0.60	0.71	L1	4.00	4.20	4.40
D	15.2	15.7	16.2	P	3.30	3.50	3.80
E	20.8	21	21.2	P1	6.80	7.10	7.40



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